



PI4ULS3V302

140Mb/s Bi-directional Level Translator for Push-Pull Applications

Features

- → 0.85V to 2.7V on A Port and 1.35V to 3.6V on B Port
- → VCCA may be greater than, equal to, or less than VCCB
- → High-Speed with 140 Mb/s Guaranteed Date Rate
- → 100 pF Capacitive Drive Capability
- → Low Bit-to-Bit Skew
- → Overvoltage Tolerant Enable and I/O Pins
- → Non-preferential Power-Up Sequencing
- ➔ Power-Off Protection
- → Package: UDFN1.2x1.6-8L, MSOP-8L

Applications

- ➔ Mobile Phones, PDAs
- ➔ Other Portable Devices

Description

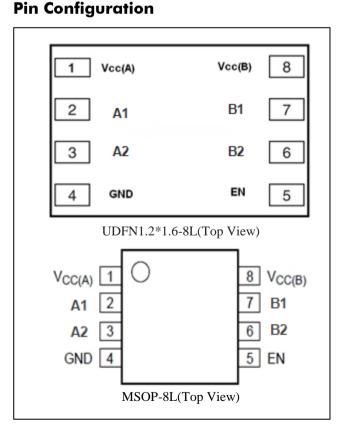
The PI4ULS3V302 is a 2-bit configurable dual-supply autosensing bidirectional level translator that does not require a direction control pin. The B and A ports are designed to track two different power supply rails, VCCB and VCCA respectively.

The PI4ULS3V302 offers the feature that the values of the VCCB and VCCA supplies are independent. Design flexibility is maximized because VCCA can be set to a value either greater than or less than the VCCB supply.

The PI4ULS3V302 has high output current capability, which allows the translator to drive high capacitive loads such as most high frequency EMI filters. Another feature of the PI4ULS3V302 is that each An and Bn channel can function as either an input or an output.

An Output Enable (EN) input is available to reduce the power consumption. The EN pin can be used to disable both I/O ports by putting them in 3-state which significantly reduces the supply current.

The PI4ULS3V302 is 2 kV System-Level ESD Capable.



Pin Description

Pin No.	Pin Name	Туре	Description
1	V _{CC(A)}	Power	A-port supply voltage.0.85V $\leq V_{CCA} \leq 2.7 \text{ V}$
2	A1	I/O	Input/output A. Referenced to V_{CCA} .
3	A2	I/O	Input/output A. Referenced to V _{CCA} .
4	GND	GND	Ground.
5	EN	Input	Output enable (active High). Pull EN low to place all outputs in 3- state mode.
6	B2	I/O	Input/output B. Referenced to V _{CCB}
7	B1	I/O	Input/output B. Referenced to V _{CCB}
8	V _{CCB}	Power	$\begin{array}{l} \text{B-port supply voltage. 1.35V} \leqslant \\ \text{V}_{\text{CCB}} \leqslant 3.6\text{V} \end{array}$





Block Diagram

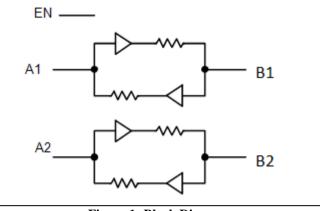


Figure 1: Block Diagram

Maximum Ratings

Storage Temperature	65°C to +150°C
Junction Temperature, Tj	
DC Supply Voltage port B	
DC Supply Voltage port A	0.5V to+3.6V
Vi(A) referenced DC Input / Output Voltage	
Vi(B) referenced DC Input / Output Voltage	
Enable Control Pin DC Input Voltage	
DC Input Diode Current(V _K GND)	
DC Output Diode Current(Vo <gnd)< td=""><td>50mA</td></gnd)<>	50mA
DC Supply Current through V _{CCB}	±100mA
DC Supply Current through V _{CCA}	±100mA
DC Ground Current through Ground Pin	

Note:

Stresses greater than those listed under MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

Recommended Operation Conditions

Symbol	Parameter			Typ.	Max.	Unit
V _{CCA}	A-side Positive DC Supply Voltag	ge	0.85	-	2.7	V
V _{CCB}	B-side Positive DC Supply Voltag	ge	1.35	-	3.6	V
VI	Enable Control Pin Voltage			-	2.7	V
V _{IO}	Due Input/Output Din Voltege	I/O A	GND	-	2.7	V
v _{IO}	Bus Input/Output Pin Voltage	I/O B	GND	-	3.6	V
T _A	Operating Temperature Range			-	+85	°C
At/Av	Input Transition Rise or Rate, V _I , 3.3 V \pm 0.3 V	0	-	10	ns	





DC Electrical Characteristics

G		T (C) ^{*1}	T . *2(T .)	T 7 *3 / T 7)	-4($0^{\circ}C$ to +	85°C	TT b
Sym	Parameter	Test Conditions ^{*1}	$V_{CCB}^{2}(V)$	$V_{CCA}^{*3}(V)$	Min.	Typ.*4	Max.	Unit
	B port Input HIGH Voltage	-	1.35-3.6	0.85-2.7	2/3*V _{CCB}	-	-	v
V _{ILB}	B port Input LOW Voltage	-	1.35-3.6	0.85-2.7	-	-	1/3* V _{ССВ}	v
V _{IHA}	A port Input HIGH Voltage	-	1.35-3.6	0.85-2.7	2/3*V _{CCA}	-	-	v
	A port Input LOW Voltage	-	1.35-3.6	0.85-2.7	-	-	1/3 * V _{CCA}	v
v	Control Pin Input HIGH Voltage	$T_A = +25 ^{\circ}C$	1.35-3.6	0.85-2.7	2/3*V _{CCA}	-	-	v
V _{IL}	Control Pin Input LOW Voltage	$T_A = +25 ^{\circ}C$	1.35-3.6	0.85-2.7	-	-	1/3 * V _{CCA}	v
V _{OHB}	B port Output HIGH Voltage	B port source current = $20\mu A$	1.35-3.6	0.85-2.7	0.9*V _{CCB}	-	-	v
	B port Output LOW Voltage	B port sink current = $20\mu A$	1.35-3.6	0.85-2.7	-	-	0.2	v
	A port Output HIGH Voltage	A port source current= $20\mu A$	1.35-3.6	0.85-2.7	0.9*V _{CCA}	-	-	v
	A port Output LOW Voltage	A port sink current = $20\mu A$	1.35-3.6	0.85-2.7	-	-	0.2	v
I _{qvb}	V _{CCB} Supply Current	$EN = V_{CCA}, I_O = 0A,$ (I/O_B=0V or V _{CCB} , I/O_A= float) or	1.35-3.6	0.85-2.7	-	-	1.5	μΑ
I _{QVA}	V _{CCA} Supply Current	$(I/O_B = \text{float}, I/O_A = 0V \text{ or } V_{CCA})$	1.35-3.6	0.85-2.7	-	-	1	μA
	B port Tristate Output Mode Supply Current	$T_A = +25$ °C, EN=0V	1.35-3.6	0.85-2.7	-	-	1.5	μΑ
I _{TS-A}	A port Tristate Output Mode Supply Current	(I/O_B = 0V or V _{CCB} , I/O_A = float) or (I/O_B = float, I/O_A = 0V or V _{CCA})	1.35-3.6	0.85-2.7	-	-	0.5	μΑ
T	I/O Tristate Output Mode Leakage Current	T_{A} = +25 °C, EN= 0V	1.35-3.6	0.85-2.7	-	-	±1	μΑ
II	Control Pin Input Current	$T_A = +25 ^{\circ}C$	1.35-3.6	0.85-2.7	-	-	±1	μΑ
			0	0	-	-	2	
I _{OFF}	Power Off Leakage Current	$I/O_B = 0$ to 3.6V, $I/O_A = 0$ to 2.5V	1.35-3.6	0	-	-	2	μA
			0	0.85-2.7	-	-	2	

Note:

1. Normal test conditions are V_I = 0V, C_{IOB} \leq 15pF and C_{IOA} \leq 15pF, unless otherwise specified.

2. V_{CCB} is the supply voltage associated with the I/O B port, and B range from +1.35 V to 3.6 V under normal operating conditions.

3. V_{CCA} is the supply voltage associated with the I/O A port, and A range from +0.85 V to 2.7V under normal operating conditions.

4. Typical values are for $V_{CCB} = +2.8V$, $V_{CCA} = +1.8V$ and $T_A = +25$ °C. All units are production tested at $T_A = +25$ °C. Limits over the operating temperature range are guaranteed by design. 5. When VCCA <1.0V, VIH is $0.75*V_{CCA}$ (Min), VIL is $0.25*V_{CCA}$ (Max)





Timing Characteristics

Sym	Parameter	Test Conditions ^{*1}	$V_{CCB}^{*2}(V)$	V _{CCA} ^{*3} (V)	-40	°C to +85	5°C	Unit
Sym	rarameter	Test Conditions	V _{CCB} (V)	V _{CCA} (V)	Min.	Typ. ^{*4}	Max.	Unit
t	B port Rise Time	$C_{IOB} = 15 \text{ pF}$	1.35-3.6	0.85-2.7	-	1.4	8.5	ns
t _{R-B}	R-B D port Kise Time	$C_{IOB} = 15 \text{ pr}$	2.5-3.6	1.8-2.7	-	1.4	3.5	115
t	t _{F-B} B port Fall Time	$C_{IOB} = 15 \text{ pF}$	1.35-3.6	0.85-2.7	-	1.2	8.5	ne
t _{F-B}	B port Fair Time	$C_{IOB} = 15 \text{ pr}^3$	2.5-3.6	1.8-2.7	-	1.2	3.5	ns
t	A port Rise Time	$C_{IOA} = 15 \text{ pF}$	1.35-3.6	0.85-2.7	-	1.3	8.5	ne
t _{R-A}	A port Kise Time	$C_{IOA} = 15 \text{ pr}^3$	2.5-3.6	1.8-2.7	-	1.3	3.5	ns
ť	A port Fall Time	$C_{IOA} = 15 \text{ pF}$	1.35-3.6	0.85-2.7	-	1.6	8.5	ne
t _{F-A}	A port Pair Time	$C_{IOA} = 15 \text{ pr}^3$	2.5-3.6	1.8-2.7	-	1.6	3.5	ns
_	B port One-Shot		1.5		-	37	-	
Z _{OB}	Output Impedance	*5	2.5	0.9-2.5	-	20	-	Ω
	1 1		3.6	0.0	-	15	-	
Z _{OA}	A port One-Shot Out-	*5	1.5-3.3	0.9 1.8	-	52 17	-	Ω
LOA	put Impedance	5	1.5-5.5	2.5	-	15	_	52
			1.35-3.6	0.85-2.7		15	35	+
		$C_{IOB} = 15 \text{ pF}$	2.5-3.6	1.8-2.7	-	-	10	-
		$C_{IOB} = 30 \text{ pF}$	1.35-3.6	0.85-2.7		_	35	-
t _{PD_A-B} Propagation Delay (Driving B port)	Propagation Dalay		2.5-3.6	1.8-2.7		_	10	-
			1.6-3.6	1.0-2.5	-		37	ns
	(Driving D poirt)	$C_{IOB} = 50 \text{ pF}$	2.5-3.6	1.8-2.7			11	-
		C _{IOB} = 100 pF	1.8-3.6	1.2-2.5	-	-	40	
			2.5-3.6	1.8-2.7		-	13	
			1.35-3.6	0.85-2.7	-	-	35	
		$C_{IOA} = 15 \text{ pF}$ $C_{IOA} = 30 \text{ pF}$	2.5-3.6	1.8-2.7	-	-	10	-
			1.35-3.6	0.85-2.7	-	-	35	
	Dress setion Deless		2.5-3.6	1.8-2.7		-	10	
t _{PD_B-A}	Propagation Delay	$C_{IOA} = 50 \text{ pF}$ $C_{IOA} = 100 \text{ pF}$				-	37	ns
	(Driving A port)		1.6-3.6 2.5-3.6	1.0-2.5	-	-	-	-
				1.8-2.7	-	-	11	-
			1.8 -3.6 2.5-3.6	1.2-2.5	-	-	40	-
4	Channel to Channel			1.8-2.7	-	-		
t _{SK}	Channel-to-Channel	$C_{IOB} = 15 pF, C_{IOA} = 15 pF^{*5}$	1.35-3.6	0.85-2.7	-	- 240	0.15	ns
_{EN-B} (t _{PZH})		$C_{IOB} = 15 pF, I/O_A = V_{CCA}$	1.35-3.6	0.85-2.7	-	240	400	-
	B port Output Enable		2.5-3.6	1.8-2.7	-	-	160	ns
$_{\rm EN-B}$ ($t_{\rm PZL}$)	Time	$C_{IOB} = 15 pF, I/O_A = 0V$	1.35-3.6	0.85-2.7	-	80	150	-
			2.5-3.6	1.8-2.7	-	- 120	130	+
$_{\rm EN-A}$ ($t_{\rm PZH}$)		$C_{IOA} = 15 pF, I/O_B = V_{CCB}$	1.35-3.6	0.85-2.7	-	130	250	-
	A port Output Enable		2.5-3.6	1.8-2.7	-	-	160	ns
_{EN-A} (t _{PZL})	ZL) Time	$C_{IOA} = 15 \text{ pF}, \text{ I/O}_B = 0 \text{ V}$	1.35-3.6	0.85-2.7	-	100	200	
			2.5-3.6	1.8-2.7	-	-	130	
_{DIS-B} (t _{PHZ})	B port Output Disable	$C_{IOB} = 15 \text{pF}, \text{I/O}_A = V_{CCA}$	1.35-3.6	0.85-2.7	-	-	210	-
		100	2.5-3.6	1.8-2.7	-	-	210	ns
$_{DIS-B}(t_{PLZ})$	Time	$C_{IOB} = 15 \text{pF}, I/O_A = 0 \text{V}$	1.35-3.6	0.85-2.7	-	-	175	4
			2.5-3.6	1.8-2.7	-	-	175	<u> </u>
_{DIS-B} (t _{PHZ})		$C_{IOB} = 15 \text{pF}, \text{I/O}A = V_{CCA}$	1.35-3.6	0.85-2.7	-	-	210	-
л <u>э</u> -д (1112)	A port Output Disable		2.5-3.6	1.8-2.7	-	-	210	ns
_{OIS-B} (t _{PLZ})	Time	$C_{IOB} = 15 \text{pF}, I/O_A = 0 \text{V}$	1.35-3.6	0.85-2.7	-	-	175	-
012-B (-1 LZ)		- IOB	2.5-3.6	1.8-2.7	-	-	175	





Timing Characteristics (Cont.)

G	D (Test Conditions ^{*1}	X 7 *2 (X 7)	V _{CCA} *3(V)	-40°C to +85°C			T T •4
Sym	Parameter		$V_{CCB}^{*2}(V)$		Min.	Typ. ^{*4}	Max.	Unit
		$C_{IO} = 15 pF$	1.35-3.6	0.85-2.7	50	-	-	
		$C_{IO} = 15 \text{pr}^3$	2.5-3.6	1.8-2.7	140	-	-	
		$C_{IO} = 30 pF$	1.35-3.6	0.85-2.7	40	-	-	
	Maximum Data Rate		2.5-3.6	1.8-2.7	120	-	-	mhna
IVIIDR	M _{IDR} Maximum Data Rate	$C_{IO} = 50 pF$	1.6-3.6	1.0-2.7	30	-	-	mbps
			2.5-3.6	1.8-2.7	100	-	-	
		$C_{IO} = 100 pF$	1.8-3.6	1.2-2.7	20	-	-	
			2.5-3.6	1.8-2.7	60	-	-	

Notes:

1. Normal test conditions are $V_I = 0$ V, $C_{IOB} \le 15 pF$ and $C_{IOA} \le 15 pF$, unless otherwise specified.

 V_{CCB} is the supply voltage associated with the I/O B port, and B ranges from +1.35 V to 3.6 V under normal operating conditions. V_{CCA} is the supply voltage associated with the I/O A port, and A ranges from +0.85 V to 2.7V under normal operating conditions. 2.

3.

4. Typical values are for B = +2.8V, A = +1.8V and T_A = +25 °C. All units are production tested at T_A = +25 °C. Limits over the operating

temperature range are guaranteed by design.

Sym ^{*1}	Parameter	Test Conditions	$V_{CCB}^{*2}(V)$	$V_{CCA}^{*3}(V)$	Тур.	Unit
C _{PD_VCCA}	A = Input port, B = Output Port B = Input port, A = Output Port	$C_{Load} = 0, f = 1MHz,$ EN = V _{CCA} (outputs enabled)	1.35-3.6	0.85-2.7	40	pF
C _{PD_VCCB}	A = Input port, B = Output Port B = Input port, A = Output Port	$C_{Load} = 0$, f = 1MHz, EN = V _{CCA} (outputs enabled)	1.35-3.6	0.85-2.7	40	pF
C _{PD_VCCA}	A = Input port, B = Output Port B = Input port, A = Output Port	$C_{Load} = 0$, f = 1MHz, EN = GND(outputs disabled)	1.35-3.6	0.85-2.7	1	pF
C _{PD_VCCB}	A = Input port, B = Output Port B = Input port, A = Output Port	$C_{Load} = 0$, f = 1MHz, EN = GND(outputs disabled)	1.35-3.6	0.85-2.7	1	pF

Power Consumption $(T_A=+25^{\circ}C)$

Notes:

1. C_{PD_VCCA} and C_{PD_VCCB} are defined as the value of the IC's equivalent capacitance from which the operating current can be calculated for the A and B power supplies, respectively. $I_{CC} = I_{CC}$ (dynamic) + I_{CC} (static) $\approx I_{CC}$ (operating) \approx CPD x V_{CC} x f_{IN} x NSW where $I_{CC} = I_{CC}$ V_{CCB} + I_{CC} V_{CCA} and NSW = total number of outputs switching.

2. V_{CCB} is the supply voltage associated with the I/O B port, and V_{CCB} ranges from +1.35V to 3.6V under normal operating conditions.

 $3.V_{CCA}$ is the supply voltage associated with the I/O A port, and V_{CCA} range from +0.0.85 V to 2.7V under normal operating conditions.

4. Typical values are at $T_A = +25 \,^{\circ}C$.



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Test Circuits

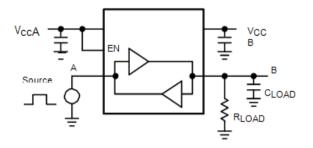


Figure 2. Driving A Test Circuit

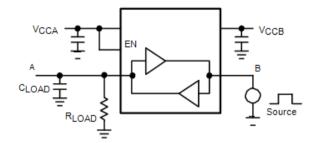


Figure 3. Driving B Test Circuit

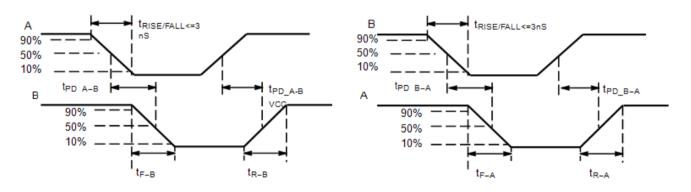
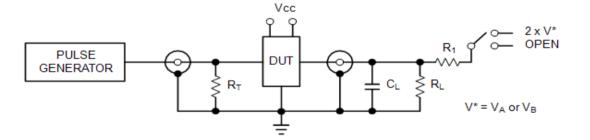


Figure 4. Definition of Timing Specification Parameters



Test	Switch
t _{PZH} , t _{PHZ}	Open
t _{PZL} , t _{PLZ}	2 x V*

 C_L = 15 pF or equivalent (Includes jig and probe capacitance) R_L = R_1 = 50 k Ω or equivalent

- $R_T = Z_{OUT}$ of pulse generator (typically 50 Ω) V* = V_A or V_B for A or B measurements,

respectively

Figure 5. Test Circuit for Enable/Disable Time Measurement



PI4ULS3V302

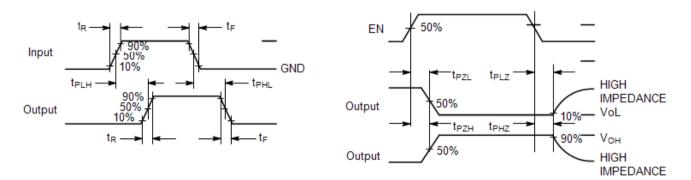


Figure 6. Timing Definitions for Propagation Delays and Enable/Disable Measurement

Functional Description

The PI4ULS3V302 is a 2-bit configurable dual-supply autosensing bidirectional level translator that does not require a direction control pin. The B and A ports are designed to track two different power supply rails, VCCB and VCCA respectively.

The PI4ULS3V302 offers the feature that the values of the VCCB and V_{CCA} supplies are independent. Design flexibility is maximized because VCCA can be set to a value either greater than or less than the VCCB supply.

The PI4ULS3V302 has high output current capability, which allows the translator to drive high capacitive loads such as most high frequency EMI filters. Another feature of the PI4ULS3V302 is that each An and Bn channel can function as either an input or an output.

An Output Enable (EN) input is available to reduce the power consumption. The EN pin can be used to disable both I/O ports by putting them in 3-state which significantly reduces the supply current.

Application Information

Level Translator Architecture

The PI4ULS3V302 auto-sense translator provides bi-directional logic voltage level shifting to transfer data in multiple supply voltage systems. These level translators have two supply voltages, VCCA and VCCB, which set the logic levels on the input and output sides of the translator. When used to transfer data from the I/O VCCA to the I/O VCCB ports, input signals referenced to the VCCA supply are translated to output signals with a logic level matched to VCCB. In a similar manner, the I/O VCCB to I/O VCCA translation shifts input signals with a logic level compatible to VCCB to an output signal matched to VCCA. The PI4ULS3V302 translator consists of bi-directional channels that independently determine the direction of the data flow without requiring a directional pin. One-shot circuits are used to detect the rising or falling input signals. In addition, the one-shots decrease the rise and fall times of the output signal for high-to-low and low-to-high transitions.

Input Driver Requirements

Auto-sense translators such as the PI4ULS3V302 have a wide bandwidth, but a relatively small DC output current rating. The high bandwidth of the bi-directional I/O circuit is used to quickly transform from an input to an output driver and vice versa. The I/O ports have a modest DC current output specification so that the output driver can be over driven when data is sent in the opposite direction. For proper operation, the input driver to the auto-sense translator should be capable of driving 3mA of peak output current. The bi-directional configuration of the translator results in both input stages being active for a very short time period. Although the peak current from the input signal circuit is relatively large, the average current is small and consistent with a standard CMOS input stage. Enable Input (EN) The PI4ULS3V302 translator has an Enable pin (EN) that provides tri–state operation at the I/O pins. Driving the Enable pin to a low logic level minimizes the power consumption of the device and drives the I/O VCCB and I/O VCCA pins to a high impedance state. Normal translation operation occurs when the EN pin is equal to a logic high signal. The EN pin is referenced to the VCCA supply and has Over-Voltage Tolerant (OVT) protection.





Uni-Directional versus Bi-Directional Translation

The PI4ULS3V302 translator can function as a non-inverting uni-directional translator. One advantage of using the translator as a uni-directional device is that each I/O pin can be configured as either an input or output. The configurable input or output feature is especially useful in applications such as SPI that use multiple uni-directional I/O lines to send data to and from a device. The flexible I/O port of the auto sense translator simplifies the trace connections on the PCB.

Power Supply Guidelines

The values of the VCCA and VCCB supplies can be set to anywhere in range 0.85-2.7V and 1.35-3.6V. Design flexibility is maximized because VCCA may be either greater than or less than the VCCB supply. The sequencing of the power supplies will not damage the device during power-up operation. In addition, the I/O VCCB and I/O VCCA pins are in the high impedance state if either supply voltage is equal to 0V. For optimal performance, 0.01 to 0.1μ F decoupling capacitors should be used on the VCCA and VCCB power supply pins. Ceramic capacitors are a good design choice to filter and bypass any noise signals on the voltage lines to the ground plane of the PCB. The noise immunity will be maximized by placing the capacitors as close as possible to the supply and ground pins, along with minimizing the PCB connection traces. The PI4ULS3V302 translators have a power down feature that provides design flexibility. The output ports are disabled when either power supply is off (VCCA or VCCB = 0V). This feature causes all of the I/O pins to be in the power saving high impedance state.

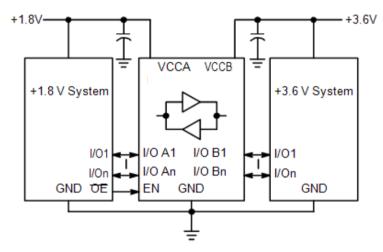


Figure 7. Typical Application Circuit

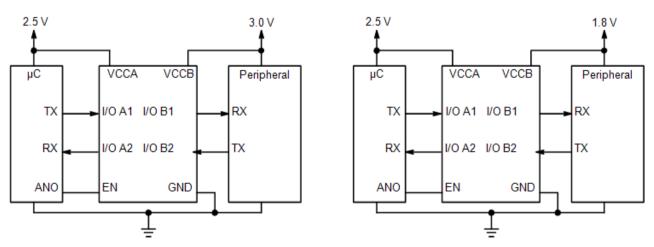


Figure 9 Application Example for A > B

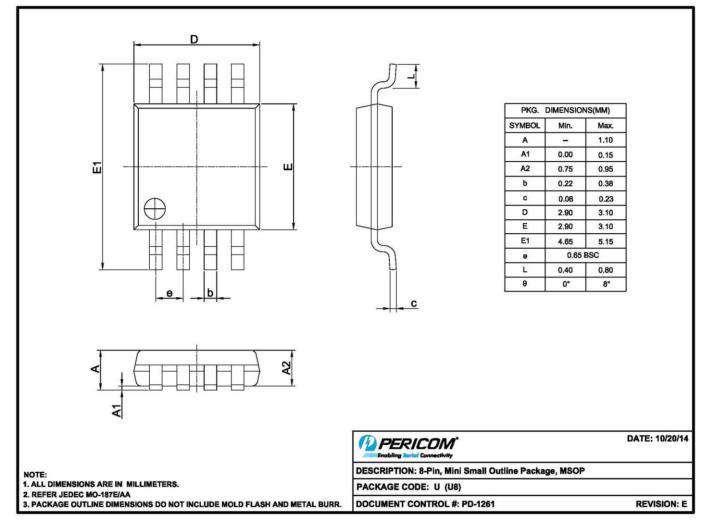
Figure 8. Application Example for A < B





Packaging Mechanical

8-MSOP (U)

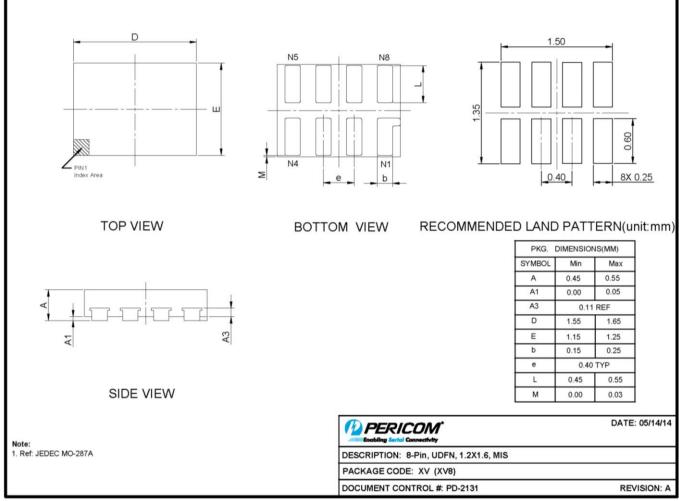




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8-UDFN (XV)

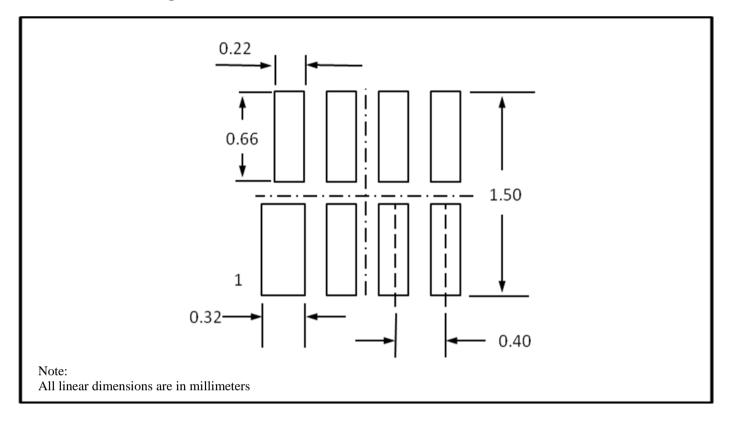


14-0141





Recommended Land pattern for UDFN1.2x1.6-8L



For latest package info.

please check: http://www.diodes.com/design/support/packaging/pericom-packaging/packaging-mechanicals-and-thermal-characteristics/

Ordering Information

Part No.	Package Code	Package
PI4ULS3V302UEX	U	8-Pin, Mini Small Outline Package (MSOP)
PI4ULS3V302XVEX	XV	8-Pin, 1.2x1.6, MIS (UDFN)

Notes:

• Thermal characteristics can be found on the company web site at www.diodes.com/design/support/packaging/

• E = Pb-free and Green

• X suffix = Tape/Reel





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